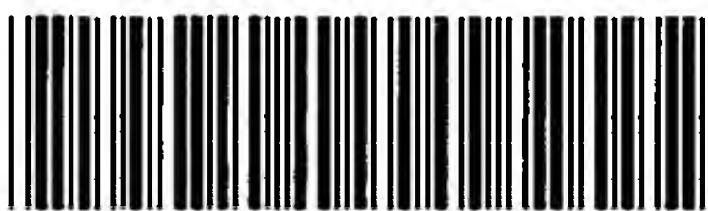


<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10568974	CHEN ET AL.
<b>Examiner</b>	<b>Art Unit</b>	
Johnson, Ryan J	2817	

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<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
331	5,86,88,90,91	1/4/2008	Ryan Johnson
313	433,153,156	1/4/2008	Ryan Johnson
315	5.13,39.51,39.63	1/4/2008	Ryan Johnson

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
See EAST history	1/4/2008	Ryan Johnson
Google search	1/4/2008	Ryan Johnson
IEEE search	1/4/2008	Ryan Johnson
Emailed Joseph Chang	1/4/2008	Ryan Johnson

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>